Component Parameter Test Instruments

NEW

A. TH2829 Series of Automatic Component Analyzer

Features

- 800×RGB×480 7-inch TFT LCD display
- Basic accuracy: 0.05%
- Test signal frequency of 1MHz, resolution of 1mHz, 5-digit frequency input
- Strongest signal source selection:
 10V/100mA programmable AC test level
 10V/100mA programmable DC bias supply
 10V/50mA standalone DC voltage source
 1A interior DC bias current source (optional)
 120A external bias source (optional)
- Maximum test speed: 9ms/time
- Simultaneous display of 4 kinds of test parameters
- 10 -point list sweep function
- Continuous curve scanning/graphical analysis function
- Internal storage of 100 sets of LCRZ setting files and 10 sets of GIF image
- GIF image and CSV data files can be saved to USB storage directly
- HANDLER, USB, LAN, RS232C, GPIB (option), DCI interface



TH2829 Series

Brief Introduction

By dint of leading impedance measurement technology and rich R&D experience, Tonghui continuously introduces representative impedance measurement product --- TH2829 series automatic component analyzer is another excellent product we have produced. TH2829 series automatic component analyzer possesses a higher test speed, a more comprehensive analysis function and friendly human-computer interactive experience by adopting the latest high-speed processor and a new software system. Well-designed measuring circuit and optimized algorithms further enhance the test stability of low-D capacitance and high-Q inductors. The instrument is provided with 10V AC test level, 10V/100mA bias current and standalone 10V/50mA DC current, making it convenient for applying in the test of all kinds of active/ passive devices. Main/ sub parameters display, enhanced display system design, 150-points list sweep and graphical analysis capabilities of multiple parameters meet the most application requirements of customers.

Thanks to the application of a new generation of processors, the instrument has a more powerful data processing capability. The test results can be easily stored in the U disk or uploaded to the upper PC or network through multiple interfaces, promoting test automation and test efficiency.

The test frequency of TH2829 series are 20Hz-300kHz, 20Hz-500kHz and 20Hz-1MHz. The instrument has a test accuracy of 0.05% and highest test speed of 9ms/time. Being equipped with multiple interfaces of HANDLER, USB, LAN, RS232C, DCI, GPIB (option) as well as rich resources, the instrument will bring excellent cost performance experience for customers.

TH2829 series automatic component analyzer is completely appropriate for test requirements of all kinds of industrial and military standards.

Specifications

Display			800×RGB×480 7-inch TFT LCD display
	TH2829A		20Hz—300kHz
	TH2829B		20Hz—500kHz
Frequency of test	TH2829C		20Hz—1MHz
signal	Minimun resolutio		1mHz, 5-digit frequency input
	Accurac	у	0.01%
	Voltage test sign	range of al	5mV—10Vrms
	Minimun resolutic voltage		100μV, 3-digit input
		ALC ON	10% x set voltage + 2mV
AC Level	Accuracy	ALC OFF	6% x set voltage + 2mV
	Current range of test signal		50µA—100mA
	Minimum resolution of current		1µA, 3-digit input
	Accuracy	ALC ON	10% x set current + 20µA
		ALC OFF	6% x set voltage + 20μA
DC	Voltage /Current range		0V— ±10V / 0mA—±100mA
bias	Resolution		0.5mV / 5µA
voltage source	Voltage accuracy		1% x set voltage + 5mV
ISO ON Be used for th	Be used for the bias test of inductanc and transformer		
AC Sou		ISO ON	100Ω
impeda		ISO OFF	30Ω 、 50Ω 、 100Ω selectable
DCR So	ource imp	edance	30Ω 、 50Ω 、 100Ω selectable
DC	Voltage /current range		0V— ±10V / 0mA—±50mA
Independent voltage	Resolution		0.5mV / 5μA
source	Voltage accuracy		1% x set voltage + 5mV
	Output resistance		100Ω
Test pa	rameters	of LCR	Ζ , Υ , C, L, X, B, R, G, D, Q, θ, DCF Vdc-Idc
Parameter display of test page			Two sets of main/sub parameters, th second set can be set as ON/OFF; There can be 10 pages of list sweep an 15 points per page at most; Multiple parameters continuous swee graphical analysis.

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	LCR test parameter		0.05%	
Basic accuracy	Calibration		Warm-up time ≥ 30 seconds; Environment temperature: 23±5°C; Signal voltage: 0.3Vrms-1Vrms Zeroing: After OPEN or SHORT; Length of test cable: 0 m	
Measur (≥10 kH	ement tin Iz)	ne	Fast: 9 ms / time Medium: 67 ms / time Slow:187 ms / time Plus the refresh time of display character	
		Z , R , X,DCR	0.00001Ω — 99.9999ΜΩ	
			0.00001µs — 99.9999s	
Diaplay range of		С	0.00001pF — 9.99999F	
		L	0.00001µH — 99.9999kH	
Display range of LCR parameter		D	0.00001 — 9.99999	
	Q	0.00001 — 99999.9		
		θ(DEG)	-179.999° — 179.999°	
		θ(RAD)	-3.14159 — 3.14159	
		Δ%	-999.999% — 999.999%	
Equival	ent circuit	t	Serial, Parallel	
Range mode			Auto, Hold	
Trigger	mode		Internal, Manual, External, Bus	
Average	e times		1–256	
Calibration function			Open, short calibration with full frequency or dot frequency, Load	
Math op	peration		Direct reading, ΔABS , $\Delta \%$	
Delay ti	me setup		0-999, minimum resolution: 100us	
Comparator			10-bin sorting, BIN1–BIN9, NG, AUX	
			Bin counter	
			PASS/FAIL on front panel, LED indication	
List sweep			·10 -point list sweep function ·List sweep of frequency, AC voltage/ current, internal/external DC bias voltage/current and independent DC source voltage can be performed on each page. Each sweep point can be sorted separately.	

 Graph scanning and analysis of frequency, AC level and DC bias is be performed. Set the sweep start point, end po and each sweep point. Display the maximum value, mini value and read any of the chosen sweep point Scanning graphs can be stored ir internal or external USB memory. 	
	nto
Internal nonvolatile 100 sets of LCRZ setting files mer 201 times test results 10 sets of GIF image, CSV data fi	
External USB memory -GIF image, CSV data files -LCRZ setting files memory -Test data can be stored via USB memory directly.	
1A bias current source 1A DC bias current source (opti can be stalled	onal)
I/O interface HANDLER on rear panel	
SCI USB、RS232C	
PCI GPIB(optional)	
Interface NI LAN	
Memory interface USB HOST(front panel)	
Bias current source control interface DCI	ce.
Bias current source control	ce.
Bias current source control interface DCI	ce.
Bias current source control interface DCI Standard configuration	ce.
Bias current source control interface DCIbe controlled by using DCI interface The maximum bias current can r 120A.General SpecificationsStandard configurationOperating temperature and humidity $0^{\circ}C - 40^{\circ}C, \le 90\%$ RHPowerVoltage $99V - 121V,$ 198V - 242V AC	ce.
Bias current source control interface DCIbe controlled by using DCI interface The maximum bias current can r 120A.General SpecificationsStandard configurationOperating temperature and humidity $0^{\circ}C - 40^{\circ}C, \le 90\%$ RHVoltage $99V - 121V,$ $400\% A 200\%$	ce.
Bias current source control interface DCIbe controlled by using DCI interface The maximum bias current can r 120A.General SpecificationsStandard configurationOperating temperature and humidity $0^{\circ}C - 40^{\circ}C, \leq 90\%$ RHPower supplyVoltage $99V - 121V,$ 	ce.
$\begin{array}{c c} \mbox{Bias current}\\ \mbox{source control}\\ \mbox{interface DCI} \end{array} \qquad \begin{array}{c} \mbox{be controlled by using DCI interface}\\ \mbox{The maximum bias current can reduce 120A.}\\ \mbox{Tandard configuration} \end{array} \\ \hline \mbox{General Specifications} \end{array} \\ \hline \mbox{General Specifications} \end{array} \\ \hline \mbox{Operating temperature}\\ \mbox{and humidity} \end{array} \qquad \begin{array}{c} \mbox{0}^{\circ}\mbox{C} - 40^{\circ}\mbox{C}, \leq 90\%\mbox{RH} \end{array} \\ \hline \mbox{Power}\\ \mbox{supply} \end{array} \\ \hline \mbox{Voltage} \qquad \begin{array}{c} \mbox{99V} - 121\mbox{V}, \\ \mbox{198V} - 242\mbox{VAC} \end{array} \\ \hline \mbox{Frequency} \qquad \mbox{47Hz} - 63\mbox{Hz} \end{array} $	ce.